Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/050,334	AGARWAL ET AL.
Examiner	Art Unit
Tuan H. Nguyen	2813

SEARCHED					
Class	Subclass	Date	Examiner		
257	updated	10/23/2006	TN		
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INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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